# Global null testing Modern Inference

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### **Outline**

- **1** The p-value
- 2 Global null testing
- 3 Maximum statistic
- **4** Sum of statistics
- **5** Higher Criticism

#### **Deterministic proof by contradiction**

- Assume a proposition, the opposite of what you think about, i.e. the opposite conclusion of your theorem
- 2 Write down a sequence of logical steps/math
- 3 Derive a contradiction
- Occide that the proposition is false (which implies that the theorem is true)

#### Stochastic proof by contradiction

- Set  $H_0$  (the proposition)
- 2 Collect data (which is noisy)
- 3 Derive an apparent contradiction (i.e. if  $H_0$  is true, then this data is very weird)
- **4** Hence we reject  $H_0$ ; this is called a "discovery"

Hypothesis testing is stochastic because we might make errors:

Type I (false discoveries) and Type II (missed discoveries)

#### **Theorem**: There is no greatest even integer.

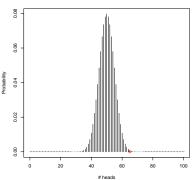
- We take the negation of the theorem and suppose it to be true: Suppose there is greatest even integer N. [We must deduce a contradiction.]
- Then, for every even integer n,  $N \ge n$ .
- Now suppose M = N + 2. Then, M is an even integer. [Because it is a sum of even integers.]
- Also, M > N [since M = N + 2].
- Therefore, *M* is an integer that is greater than the greatest integer.
- This contradicts the supposition that N ≥ n for every even integer n. [Hence, the supposition is false and the statement is true.]
  - And this completes the proof.

Assume we have a coin and want to determine whether or not it is fair. In this case we have

 $H_0$ : Coin is fair  $(\theta = 1/2)$ 

 $H_1$  : Coin is biased ( heta 
eq 1/2)

The probability distribution of X= "the number of heads in 100 trials" under  $H_0$  is Binomial(n=100,  $\theta=1/2$ ). After tossing the coin n=100 times we then get x=65 heads and n-x=35 tails.



- Is this then enough to reject  $H_0$ ?
- To determine this we calculate a *p*-value associated with our observed data assuming the null hypothesis
- A p-value is the probability of seeing what you saw or something more extreme - given that H<sub>0</sub> is true.
- Small p-values imply an unexpected outcome, given that the null (H<sub>0</sub>) is true
- So if p = 0.0018 then either  $H_0$  isn't true or we are really unlucky and saw this data

### The *p*-value

- Choose a test statistic T = t(Y), large values of which cast doubts on  $H_0$
- Observe the data  $y_{obs}$ , realization of Y

•

$$p_{\rm obs} = P_0(T \ge t_{\rm obs})$$

where  $t_{\rm obs} = t(y_{obs})$  and  $P_0$  is the probability under  $H_0$ 

### *p*-value null distribution

- $p_{\rm obs} = 1 F_0(t_{\rm obs})$ , where  $F_0$  is the null distribution function of T, supposed to be continuous and invertible.
- One interpretation of  $p_{\rm obs}$  stems from the corresponding random variable  $P=1-F_0(T)$
- The null distribution of P is Uniform(0,1): for any  $u \in (0,1)$ ,

$$P_0(P \le u) = P_0(F_0^{-1}(1-u) \le T) = 1 - F_0(F_0^{-1}(1-u)) = u$$



#### One- and two-sided tests

- Suppose that we have a test statistic T with continuous distribution, small and large values of which indicate a departure from H<sub>0</sub>
- Calculate

$$p_{\mathrm{obs}}^- = \mathrm{P}_0(T \leq t_{\mathrm{obs}}), \quad p_{\mathrm{obs}}^+ = \mathrm{P}_0(T \geq t_{\mathrm{obs}})$$

• The *p*-value is

$$p_{\mathrm{obs}} = 2 \min(p_{\mathrm{obs}}^-, p_{\mathrm{obs}}^+)$$

This follows because the null distribution of  $Q = \min(P^-, P^+)$  is

$$Q = \min(1 - U(0,1), U(0,1)) = U(0,1/2)$$

thus the null distribution of 2Q is U(0,1)



### Discrete null distribution

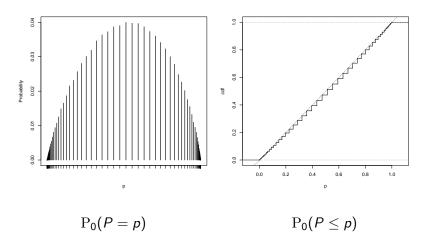
- Suppose  $T \sim \text{Poisson}(\mu)$  and we observe  $t_{\text{obs}} = 3$
- We want to test  $H_0: \mu = 2$  vs  $H_1: \mu \neq 2$

•

$$p_{\mathrm{obs}}^{+} = \mathrm{P_0}(T \geq t_{\mathrm{obs}}) = \sum_{t=t_{\mathrm{obs}}}^{\infty} \frac{\mu^t e^{-\mu}}{t!}$$

$$ho_{\mathrm{obs}}^- = \mathrm{P_0}(T \leq t_{\mathrm{obs}}) = \sum_{t=0}^{t_{\mathrm{obs}}} \frac{\mu^t e^{-\mu}}{t!}$$

With discrete null distribution,  $p_{\rm obs}$  is  $q_{\rm obs} = {\rm min}(p_{\rm obs}^-, p_{\rm obs}^+)$  plus the achievable p-value from the other tail of the distribution nearest to but not exceeding  $q_{\rm obs}$ 



Example of null discrete distribution (pmf and cdf) of the p-value

### Valid *p*-values

We have a *valid test* if the *p*-value is uniformly distributed under  $H_0$ , i.e.

$$P_0(P \le u) = u \quad \forall u \in (0,1)$$

or more generally (e.g. for discrete null distributions) if the p-value is  $stochastically\ dominated$  by the uniform distribution under  $H_0$ , i.e.

$$P_0(P \le u) \le u \quad \forall u \in (0,1)$$

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### Inference on the mean

$$y \sim N_m(\mu, \Sigma)$$

where  $y=(y_1,\ldots,y_m)^{\mathsf{T}}$  is the response,  $\mu=(\mu_1,\ldots,\mu_m)^{\mathsf{T}}$  is the mean vector (where  $\mu_i=0$  means "no effect" and  $\mu_i\neq 0$  means "effect") and  $\Sigma$  is the correlation matrix. Marginally,  $y_i\sim N(\mu_i,1)$ 

Consider the following questions:

- **①** Detecting effects: There is at least one  $\mu_i$  different from 0?
- **2** Counting effects: How many  $\mu_i$  are different from 0?
- **3** *Identifying effects*: Which  $\mu_i$  are different from 0?

### Global null

Testing the global null hypothesis aims at detecting any effect

$$H_0: \mu = 0$$
, i.e.  $\mu_i = 0$  for all  $i = 1, ..., m$   
 $H_1: \mu \neq 0$ , i.e.  $\mu_i \neq 0$  for at least one  $i$ 

One-sided alternative

$$H_0$$
:  $\mu_i = 0$  for all  $i = 1, ..., m$   
 $H_1$ :  $\mu_i > 0$  for at least one  $i$ 

We will consider three different tests (one-sided alternative):

- Maximum statistic:  $T_{\text{max}} = \max(y_1, \dots, y_m)$
- Sum of statistics  $T_{\text{sum}} = \sum_{i=1}^{m} y_i$
- Higher criticism

For simplicity, assume that the  $y_i$ s are independent (i.e.  $\Sigma = I_m$ )



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### Maximum statistic

• The critical value  $t_{1-\alpha}$  of the test based on the maximum statistic is

$$P_0(T_{\max} \ge t_{1-\alpha}) = \alpha$$

where  $t_{1-\alpha}$  is the  $1-\alpha$  quantile of the distribution of the maximum of m independent standard normal variables

$$\int_{t_{1-\alpha}}^{\infty} m\phi(y)\Phi(y)^{m-1}dy = \alpha$$

where  $\phi$  and  $\Phi$  are the density and cdf of  $\mathcal{N}(0,1)$ 

### Minimum *p*-value

• Equivalently, define  $p_i = 1 - \Phi(y_i) \stackrel{H_0}{\sim} U(0,1)$  and use the minimum p-value

$$p_{\min} = \min(p_1, \ldots, p_m) \stackrel{H_0}{\sim} \operatorname{Beta}(1, m)$$

- The MinP test rejects  $H_0$  if  $p_{\min} \leq 1 (1-lpha)^{rac{1}{m}}$
- To see this

$$P_{0}(p_{\min} \leq 1 - (1 - \alpha)^{\frac{1}{m}}) = 1 - P_{0}\left(\bigcap_{i=1}^{m} \{p_{i} > 1 - (1 - \alpha)^{\frac{1}{m}}\}\right)$$
$$= 1 - [(1 - \alpha)^{\frac{1}{m}}]^{m} = \alpha$$

### Approximated critical value

• Replace  $t_{1-\alpha}$  by  $z_{1-\alpha/m}$ , where  $z_{\alpha}$  is the  $\alpha$  quantile of N(0,1)

$$P_0(T_{\max} \ge z_{1-\alpha/m}) = P_0\left(\bigcup_{i=1}^m \{y_i \ge z_{1-\alpha/m}\}\right)$$

$$\le \sum_{i=1}^m P_0(y_i \ge z_{1-\alpha/m}) = m\frac{\alpha}{m} = \alpha$$

• The union bound might seem crude, but with independent  $y_i$ s the size of the test is very near  $\alpha$ 

$$P_0(T_{\max} \ge z_{1-\alpha/m}) = 1 - \prod_{i=1}^m P_0(y_i < z_{1-\alpha/m})$$
$$= 1 - \left(1 - \frac{\alpha}{m}\right)^m \stackrel{m \to \infty}{\to} 1 - e^{-\alpha} \approx \alpha$$

For  $\alpha = 0.05$ , the size is 0.0487 (asymptotically)

# Magnitude of the critical value

• We have

$$P(Z > t) \le \frac{\phi(t)}{t}$$

• To see this

$$\int_{t}^{\infty} \frac{1}{\sqrt{2\pi}} e^{-z^{2}/2} dz < \frac{1}{t\sqrt{2\pi}} \int_{t}^{\infty} z e^{-z^{2}/2} dz = \frac{1}{t\sqrt{2\pi}} e^{-t^{2}/2}$$

· It follows that

$$P(Z > \sqrt{2\log m}) \le \frac{\phi(\sqrt{2\log m})}{\sqrt{2\log m}} = \frac{1}{2m\sqrt{\pi\log m}} < \frac{\alpha}{m}$$

as soon as 
$$\sqrt{\log m} > \frac{1}{2\sqrt{\pi}\alpha}$$

• Therefore  $z_{1-\alpha/m} \leq \sqrt{2\log m}$  if  $\sqrt{\log m} > \frac{1}{2\sqrt{\pi}\alpha}$ 

### Magnitude of the critical value

- It can be proved that  $(1-1/t^2)\frac{\phi(t)}{t} < \mathrm{P}(Z>t)$
- Then, for any fixed  $\alpha$  and  $\epsilon > 0$ , the following inequalities hold for all large enough m:

$$\sqrt{(1-\epsilon)2\log(m)} \le z_{1-\alpha/m} \le \sqrt{2\log(m)}$$

Hence,  $z_{1-\alpha/m}$  grows like  $\sqrt{2 \log m}$ 

• For large m, the maximum test rejects  $H_0$  when

$$T_{\max} \ge \sqrt{2 \log m}$$

and there is (asymptotically) no dependence on lpha

# Needle in a haystack problem

$$H_0: \mu_i = 0 \text{ for all } i = 1, \dots, m$$
  
 $H_1: \mu_i = c > 0, \mu_j = 0 \text{ for } j \neq i$ 

• What is the limiting power of the test?

$$\lim_{m\to\infty} P_1(T_{\max} > z_{1-\alpha/m})$$

• The answer to this question depends on the limiting ratio

$$\lim_{m\to\infty}\frac{c}{\sqrt{2\log m}}$$

where c = c(m) is the value of the single non-zero mean, which is a function of m

### Needle in a haystack problem

#### Two cases:

• Suppose  $c > (1 + \epsilon)\sqrt{2\log m}$ . Then, assuming without loss of generality that  $\mu_1 = c$ ,

$$P_1(T_{\max} > z_{1-\alpha/m}) \ge P_1(y_1 > z_{1-\alpha/m}) = P(Z > z_{1-\alpha/m} - c) \to 1$$

• Suppose  $c < (1+\epsilon)\sqrt{2\log m}$ . Then

$$\begin{aligned} \mathrm{P}_{1}(T_{\mathrm{max}} > z_{1-\alpha/m}) & \leq & \mathrm{P}(y_{1} > z_{1-\alpha/m}) + \mathrm{P}(\max_{i > 1} y_{i} > z_{1-\alpha/m}) \\ & = & \mathrm{P}(Z > z_{1-\frac{\alpha}{m}} - c) + \mathrm{P}(\max_{i > 1} y_{i} > z_{1-\frac{\alpha}{m}}) \\ & \rightarrow & 0 + (1 - e^{-\alpha}) \approx \alpha \end{aligned}$$

• Can we do better than this test? No, it is asymptotically equivalent to optimal test given by Neyman-Pearson lemma

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### Sum of statistics

$$T_{\text{sum}} = \sum_{i=1}^{m} y_i \sim N(\sum_{i=1}^{m} \mu_i, m)$$

- $Z_{\mathrm{sum}} = \frac{T_{\mathrm{sum}}}{\sqrt{m}} \stackrel{H_0}{\sim} N(0,1)$
- $Z_{\mathrm{sum}} \overset{H_1}{\sim} \mathcal{N}(\theta,1)$  where  $\theta = \frac{\sum_{i=1}^m \mu_i}{\sqrt{m}}$
- If  $\theta \to 0$  when  $m \to \infty$ , then the test has no power
- By the Neyman-Pearson lemma,  $T_{\rm sum}$  is the uniformly most powerful (UMP) test for testing against a dense alternative with constant effect:

 $H_0: \mu_i = 0$  for all i $H_1: \mu_i = c > 0$  for all i

• Here  $\theta = \sqrt{mc}$ , but if  $c = \frac{1}{m}$  the optimal test has no power



### Comparison

The two test are effective in two different regimes:

#### • Few strong effects:

 $m^{1/4}$  of the  $\mu_i$ s are equal to  $\sqrt{2\log m}$ , the rest 0. E.g. when  $m=10^6$ ,  $n^{1/4}\approx 36$  and  $\sqrt{2\log m}\approx 5.3$ . In this setting  $T_{\rm max}$  has full power, but  $T_{\rm sum}$  has no power because

$$\theta = \frac{m^{1/4}\sqrt{2\log m}}{\sqrt{m}} \to 0$$

#### • Small, distributed effects:

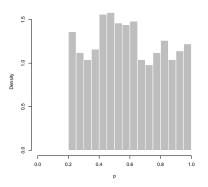
 $\sqrt{2m}$  of the  $\mu_i$ s are equal to 3, the rest 0.

The  $T_{\mathrm{sum}}$  has (almost) full power, but  $T_{\mathrm{max}}$  has no power because when m is large it's very likely that the largest  $y_i$  value comes from a null  $\mu_i$ , not a true signal. An intuitive argument is as follows: among the nulls, the largest  $y_i$  has size  $\approx \sqrt{2\log m}$  while among the true signals, the largest  $y_i$  has size  $\approx 3 + \sqrt{2\log \sqrt{2m}}$ . If m is large, the former is larger

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- Suppose that  $p_1, \ldots, p_m$  are independent and  $p_i \stackrel{H_0}{\sim} U(0,1)$
- For m = 1000 you observe the following histogram of p-values:



- Would you reject the global null hypothesis  $H_0$ ?
- Note that in this case  $H_0: p_1, \ldots, p_m$  i.i.d. U(0,1)

### Kolmogorov-Smirnov test

- ullet Consider the empirical CDF  $\hat{F}_m(t) = rac{\sum_{i=1}^m \mathbb{1}\{p_i \leq t\}}{m}$
- Under  $H_0$ , each  $p_i$  has marginal distribution U(0,1) thus  $\mathbb{E}_0(\hat{F}_m(t)) = t$
- Moreover, if we assume that  $p_i$ s are independent, i.e.  $p_1, \ldots, p_m$  i.i.d. U(0,1) under  $H_0$ , then

$$m\hat{F}_m(t) \sim \text{Binomial}(m, t)$$

 Hence, we measure the distance between what we observe and what we expect and reject if the difference is large, e.g. the Kolmogorov-Smirnov test statistic

$$T_{\mathrm{KS}} = \sup_{t \in [0,1]} |\hat{F}_m(t) - F(t)|$$



### **Dvoretzky-Kiefer-Wolfowitz inequality**

Given m, let X<sub>1</sub>,..., X<sub>M</sub> be real-valued i.i.d. r.v. with cdf F and let F̂<sub>m</sub> denote the associated ecdf. Then for a given constant ε > 0

$$\mathrm{P}(\|\hat{F}_m-F\|_{\infty}>\epsilon)\leq 2e^{-2m\epsilon^2}$$
 where  $\|\hat{F}_m-F\|_{\infty}=\sup_{t\in[0,1]}|\hat{F}_m(t)-t|$ .

• It can be rephrased as follows:

$$\|\hat{F}_m - F\|_{\infty} \le \sqrt{\frac{\log \frac{2}{\alpha}}{2m}}$$

with probability  $\geq 1 - \alpha$ 

### Higher criticism

• This test statistic is designed to take account for the variance in the Binomial distribution of the statistic  $T_{\rm KS}$ 

$$T_{
m HC} = \sup_{0 \leq t \leq lpha_0} rac{\hat{F}_m(t) - t}{\sqrt{t(1-t)/m}}$$

• It can be equivalently written as follows:

$$T_{\mathrm{HC}} = \max_{0 \leq i \leq m\alpha_0} T_i, \quad T_i = \sqrt{m} \frac{(i/m) - p_{(i)}}{\sqrt{p_{(i)}(1 - p_{(i)})}}$$

where  $p_{(1)} \leq \ldots \leq p_{(n)}$  are the sorted p-values



### Critical value

- $T_{\rm HC}$  can be connected with the maximum of a standardized empirical process. For  $m \to \infty$ ,  $b_m T_{\rm HC} c_m$  converges weakly to the standard Gumbel distribution, where  $b_m = \sqrt{2\log\log m}$  and  $c_m = \frac{1}{2}(\log\log\log(m) 4\pi)$
- For any fixed  $\alpha$  and  $m \to \infty$ , the  $1-\alpha$  quantile of the null distribution for  $T_{\rm HC}$  is

$$t_{1-lpha} pprox (1+a)\sqrt{2\log\log m}$$

for some a>0, e.g. a=1.08 for  $m\approx 10^6$ ,  $\alpha_0=1$  and  $\alpha=0.05$  by simulations



### Mixture distribution

• We assume that our samples follow a mixture of N(0,1) and  $N(\mu,1)$  distributions with  $\mu$  fixed, resulting in

$$H_0 : X_i \stackrel{i.i.d}{\sim} N(0,1)$$
 $H_1 : X_i \stackrel{i.i.d}{\sim} \pi_0 N(0,1) + \pi_1 N(\mu,1)$ 

where  $\pi_1 = 1 - \pi_0$ 

• To carry out asymptotic analysis, we must specify the dependence scheme of  $\pi_1 = \pi_1(m)$  and  $\mu = \mu(m)$  on m:

$$\pi_1 = m^{-eta} \qquad rac{1}{2} < eta < 1$$
  $\mu = \sqrt{2r\log m} \qquad 0 < r < 1$ 

• Note that The needle in a haystack problem corresponds to  $\beta=1$  and r=1; the small distributed effects case corresponds to  $\beta=1/2$ 



#### Threshold curve

The following threshold curve for *r* 

$$\rho_{\rm HC}(\beta) = \begin{cases} \beta - \frac{1}{2} & \text{if } \frac{1}{2} < \beta \le \frac{3}{4} \\ (1 - \sqrt{1 - \beta})^2 & \text{if } \frac{3}{4} \le \beta \le 1 \end{cases}$$

is such that

• If  $r > \rho_{\mathrm{HC}}(\beta)$  the Neyman-Pearson optimal test achieves

$$P_0(\text{Type I Error}) + P_1(\text{Type II Error}) \rightarrow 0$$

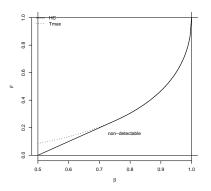
The Higher Criticism is asymptotically equivalent to the optimal test without knowledge of  $\pi_1$  and/or  $\mu$ 

• If  $r < \rho_{HC}(\beta)$  then for any test

$$\liminf_{m \to} \infty \ \mathrm{P_0}(\mathrm{Type} \ \mathrm{IError}) + \mathrm{P_1}(\mathrm{Type} \ \mathrm{IIError}) \geq 1$$



# **Detectable region**



$$\rho_{\mathrm{Tmax}}(\beta) = (1 - \sqrt{1 - \beta})^2$$